

$\begin{array}{c} \text{October} \\ \textbf{UniFET}^{\text{TM}} \end{array}$

FDB38N30U

N-Channel MOSFET, U-FRFET 300V, 38A, 0.12Ω

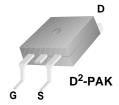
Features

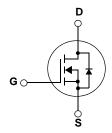
- $R_{DS(on)} = 0.103\Omega$ (Typ.) @ $V_{GS} = 10V$, $I_D = 19A$
- Low gate charge (Typ. 56nC)
- Low C_{rss} (Typ. 55pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These device are well suited for high efficient switched mode power supplies and active power factor correction.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol		Parameter		Ratings	Units	
V _{DSS}	Drain to Source Voltage			300	V	
V _{GSS}	Gate to Source Voltage			±30	V	
	Drain Current	-Continuous (T _C = 25°C)		38	^	
I _D	DrainGurient	-Continuous (T _C = 100°C)		22.8	A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	152	А	
E _{AS}	Single Pulsed Avalanche Er	nergy	(Note 2)	722	mJ	
I _{AR}	Avalanche Current		(Note 1)	38	Α	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	31.3	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns	
D	Davies Dissipation	$(T_C = 25^{\circ}C)$		313	W	
P_D	Power Dissipation	- Derate above 25°C		2.5	W/°C	
T _J , T _{STG}	Operating and Storage Tem	perature Range		-55 to +150	°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.4	
$R_{\theta CS}$	Thermal Resistance, Case to Sink -		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 62.5		

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB38N30U	FDB38N30U	D2-PAK	330mm	24mm	800

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_J = 25 ^{\circ} C$	300	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.33	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 300V, V_{GS} = 0V$	-	-	25	μА
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 240V, T_{C} = 125^{\circ}C$	-	-	250	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 19A$	-	0.103	0.120	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 20V, I_D = 19A$ (Note 4)	-	30	i	S

Dynamic Characteristics

C _{iss}	Input Capacitance	.,, .,		2510	3340	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ — f = 1MHz	-	470	625	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	-	55	85	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	56	73	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 240V, I_{D} = 38A$	-	14	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4, 5)	-	24	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	33	76	ns
t _r	Turn-On Rise Time	$V_{DD} = 150V, I_{D} = 38A$		-	80	170	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$		-	133	276	ns
t _f	Turn-Off Fall Time		(Note 4, 5)	-	62	134	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	-	38	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	152	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 38A$		=	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 38A$		=	60	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	=	0.097	-	μС

- **Notes:**1: Repetitive Rating: Pulse width limited by maximum junction temperature
- 2: L = 1mH, I_{AS} = 38A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C 3: I_{SD} \leq 38A, di/dt \leq 200A/ μ s, V_{DD} \leq BV $_{DSS}$, Starting T_J = 25 $^{\circ}$ C 4: Pulse Test: Pulse width \leq 300 μ s, Duty Cycle \leq 2%
- 5: Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

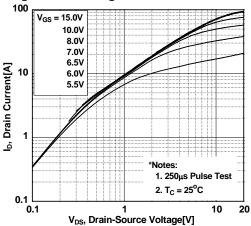


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

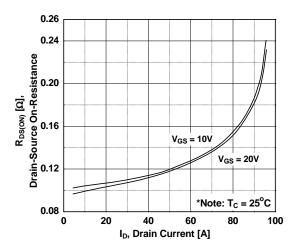


Figure 5. Capacitance Characteristics

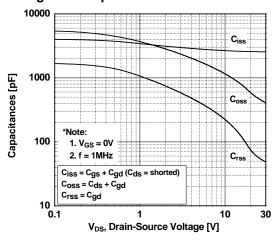


Figure 2. Transfer Characteristics

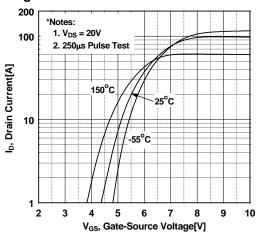


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

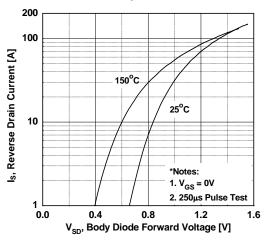
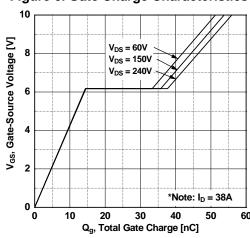


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

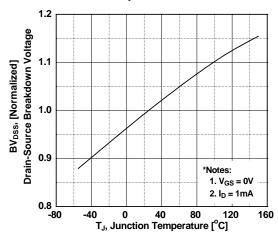


Figure 9. Maximum Drain Current vs. Case Temperature

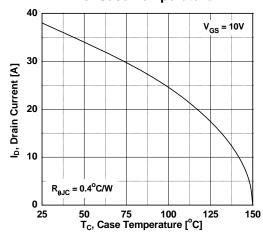


Figure 8. Maximum Safe Operating Area

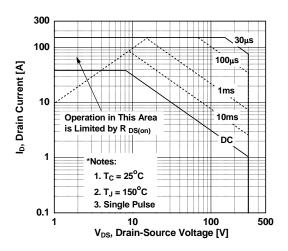


Figure 10. Unclamped Inductive Switching Capability

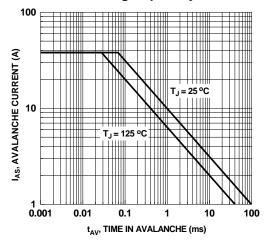
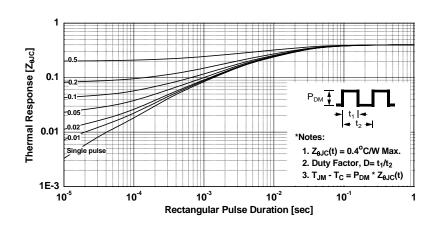
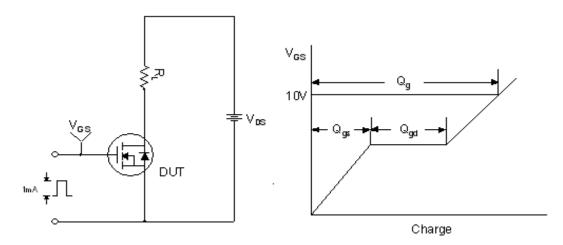


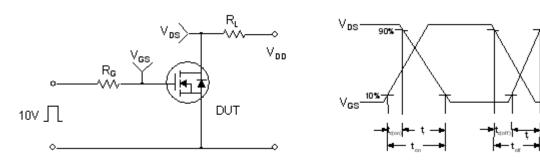
Figure 11. Transient Thermal Response Curve



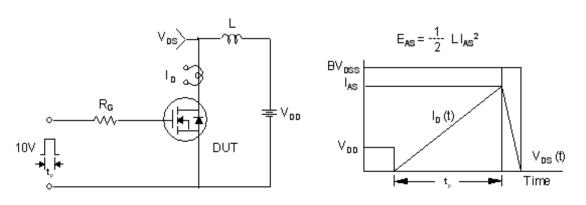
Gate Charge Test Circuit & Waveform



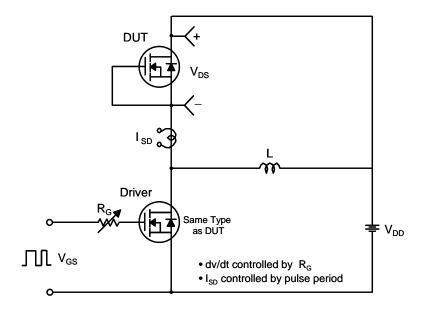
Resistive Switching Test Circuit & Waveforms

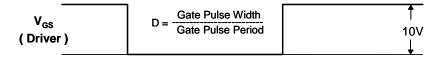


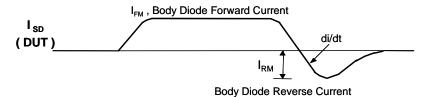
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Recovery dv/dt

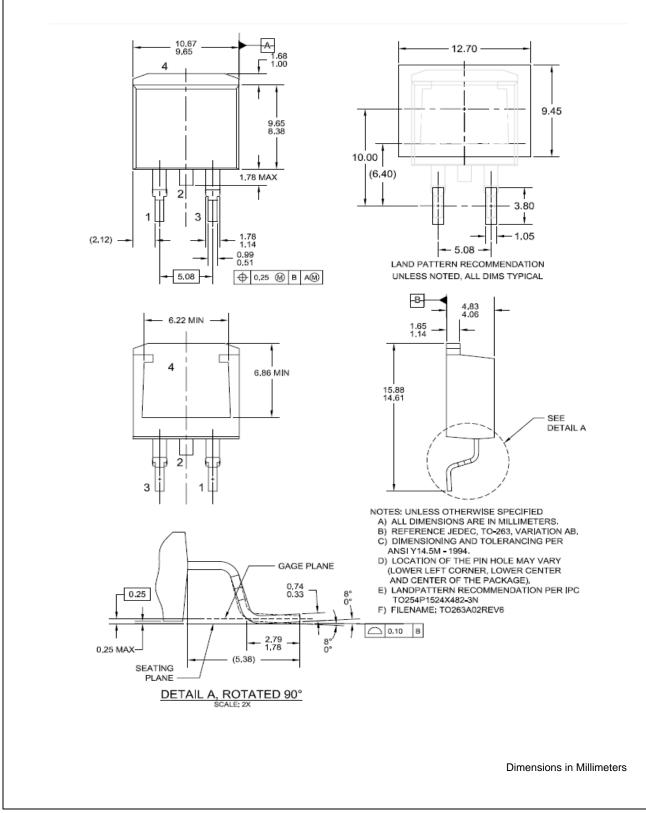
V_{SD}

Body Diode

Forward Voltage Drop

Mechanical Dimensions

D²PAK







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